

## **Description**

The XPX40200TU uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

#### **General Features**

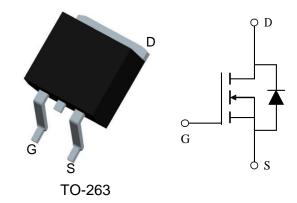
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E<sub>AS</sub>
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

### **Application**

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



 $V_{DS}$  =40V, $I_{D}$  =300A  $R_{DS}(ON)$ =1.2mΩ (typ) @  $V_{GS}$ =10V  $R_{DS}(ON)$ =1.6mΩ (typ) @  $V_{GS}$ =4.5V



## **Package Marking and Ordering Information**

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
XPX40200TU	XPX40200TU	TO-263-2L	-	-	-

# Absolute Maximum Ratings (T<sub>A</sub>=25 ℃ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	40	V
Gate-Source Voltage	V <sub>G</sub> s	±20	V
Drain Current-Continuous	I <sub>D</sub>	300	Α
Drain Current-Continuous(T <sub>C</sub> =100 °C)	I <sub>D</sub> (100℃)	235	Α
Pulsed Drain Current	I <sub>DM</sub>	920	А
Maximum Power Dissipation	P <sub>D</sub>	370	W
Derating factor		2.5	W/°C
Single pulse avalanche energy (Note 5)	E <sub>AS</sub>	2600	mJ
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 175	$^{\circ}$
Thermal Resistance,Junction-to-Case <sup>(Note 2)</sup>	R <sub>eJC</sub>	0.45	°C/W



# Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

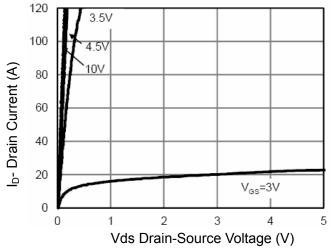
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics	<u>.</u>					
Drain-Source Breakdown Voltage	ge $BV_{DSS}$ $V_{GS}$ =0 $V_D$ =250 $\mu$ A		40		-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =40V,V <sub>GS</sub> =0V	-	-	1	μΑ
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)	•		•			
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA	1.3	1.8	2.5	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =150A	-	1.2	1.5	mΩ
Forward Transconductance	<b>g</b> Fs	V <sub>DS</sub> =5V,I <sub>D</sub> =150A	-	100	-	S
Dynamic Characteristics (Note4)	•		•			
Input Capacitance	C <sub>lss</sub>	\/ Q5\/\/ 0\/	-	9896	-	PF
Output Capacitance	Coss	$V_{DS}$ =25V, $V_{GS}$ =0V,	-	1460	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F=1.0MHz	-	1229	-	PF
Switching Characteristics (Note 4)	•		•			
Turn-on Delay Time	t <sub>d(on)</sub>		-	42	-	nS
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}$ =20 $V$ , $R_L$ =15 $\Omega$ ,	-	41	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_G$ =2.5 $\Omega$ , $V_{GS}$ =10 $V$	-	150	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	70	-	nS
Total Gate Charge	Qg		-	249	-	nC
Gate-Source Charge	Q <sub>gs</sub>	I <sub>D</sub> =150A,V <sub>DD</sub> =20V,V <sub>GS</sub> =10V	-	40	-	nC
Gate-Drain Charge	$Q_{gd}$		-	80	-	nC
Drain-Source Diode Characteristics	•		•			
Diode Forward Voltage (Note 3)	$V_{SD}$	V <sub>GS</sub> =0V,I <sub>S</sub> =150A	-	0.85	1.2	V
Diode Forward Current (Note 2)	Is		-	-	300	Α
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25°C, I <sub>F</sub> = 300A	-	55		nS
Reverse Recovery Charge	Qrr	di/dt = 100A/µs <sup>(Note3)</sup>	-	180		nC

#### Notes:

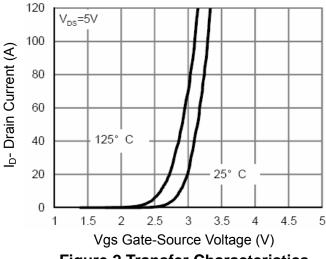
- $\textbf{1.} \ \textbf{Repetitive Rating: Pulse width limited by maximum junction temperature.}$
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width  $\leq$  300 $\mu$ s, Duty Cycle  $\leq$  2%.
- **4.** Guaranteed by design, not subject to production
- 5. EAS condition: Tj=25  $^{\circ}\text{C}\text{,V}_{DD}\text{=}20\text{V,V}_{G}\text{=}10\text{V,L=}0.5\text{mH,Rg=}25\Omega$



# Typical Electrical and Thermal Characteristics (Curves)



**Figure 1 Output Characteristics** 



**Figure 2 Transfer Characteristics** 

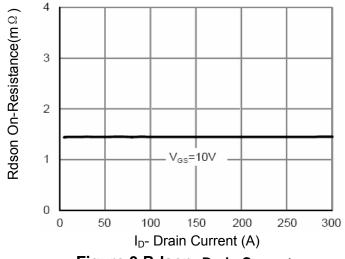


Figure 3 Rdson- Drain Current

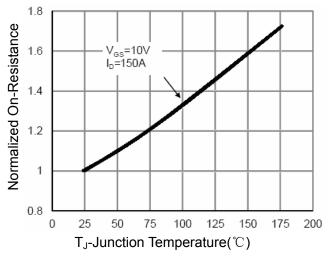
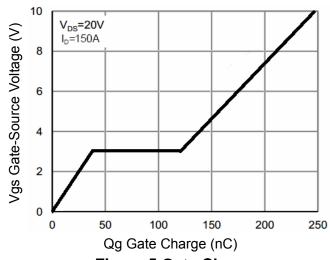


Figure 4 Rdson-JunctionTemperature



**Figure 5 Gate Charge** 

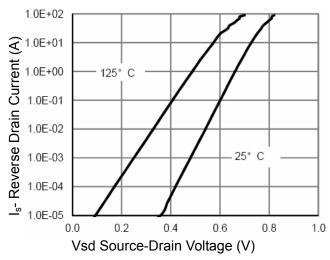


Figure 6 Source- Drain Diode Forward



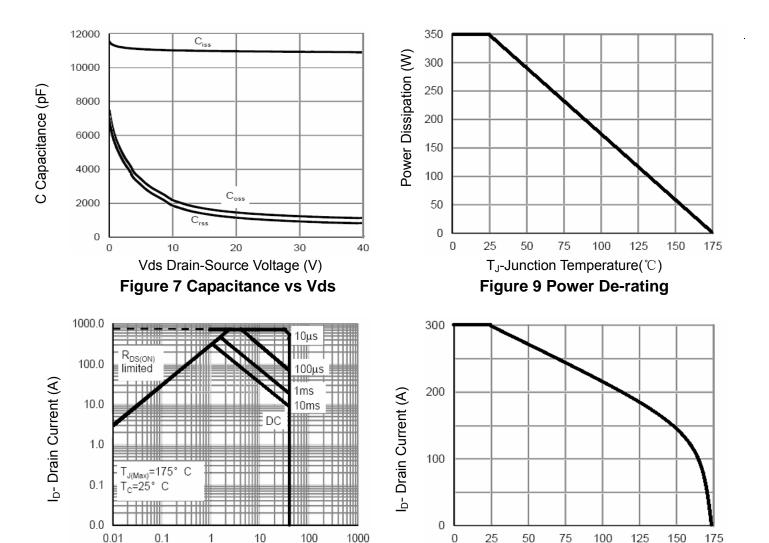
Vds Drain-Source Voltage (V)

**Figure 8 Safe Operation Area** 

### 40V N-ChannelEnhancement Mode MOSFET

T<sub>J</sub>-Junction Temperature(°C)

Figure 10 Current De-rating



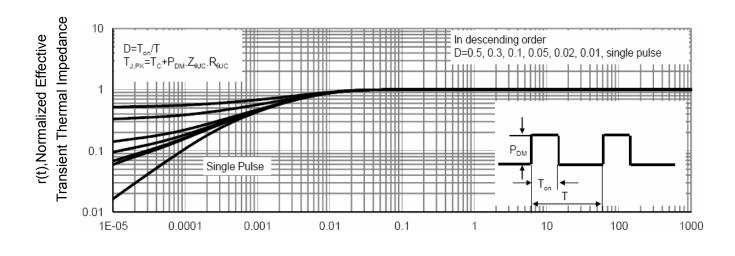
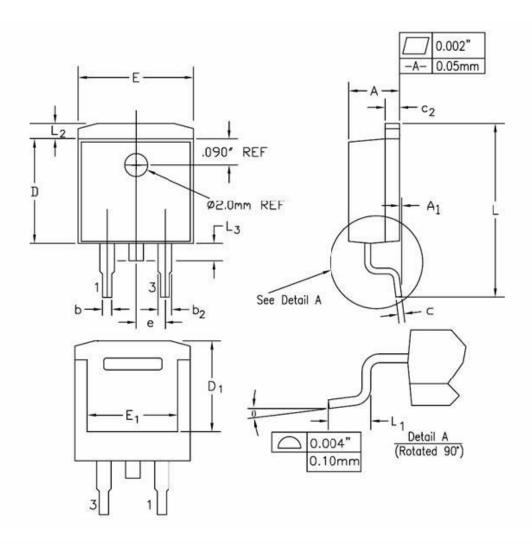


Figure 11 Normalized Maximum Transient Thermal Impedance

Square Wave Pluse Duration (sec)



# **TO-263-2L Package Information**



SYMBOL	INCHES		MILLIM	NOTES	
STIVIDOL	MIN	MAX	MIN	MAX	NOTES
Α	0.170	0.180	4.32	4.57	
A1	-	0.010	-	0.25	
b	0.028	0.037	0.71	0.94	
b2	0.045	0.055	1.15	1.40	
С	0.018	0.024	0.46	0.61	
c2	0.048	0.055	1.22	1.40	
D	0.350	0.370	8.89	9.40	
D1	0.315	0.324	8.01	8.23	
E	0.395	0.405	10.04	10.28	
E1	0.310	0.318	7.88	8.08	
e	0.100 BSC.		2.54 BSC.		
L	0.580	0.620	14.73	15.75	
L1	0.090	0.110	2.29	2.79	
L2	0.045	0.055	1.15	1.39	
L3	0.050	0.070	1.27	1.77	
θ	0°	8°	0°	8°	



Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time		
Pb device	<b>245℃±5℃</b>	5sec±1sec		
Pb-Free device	260℃+0/-5℃	5sec±1sec		



This integrated circuit can be damaged by ESD UniverChip Corporation recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedure can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

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